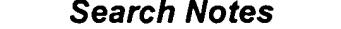


Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/652,653	TANAKA ET AL.
	Examiner	Art Unit
	Viet Q. Nguyen	2827

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
365	63	8/31/2005	V.N
710	305	8/31/2005	V.N